WinhiSemi

WLDE003R170NA



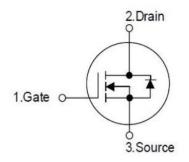
$17m\Omega$, 30V, N-Channel Power MOSFET

WLDE003R170NA

General Description

WLDE003R170NA N-Channel MOSFET is based on unique device design to achieve low RDS_(ON), low gate charge, fast switching and excellent avalanche characteristics.

Symbol



Symbol of WLDE003R170NA

Features

- Low RDS(ON) & FOM
- $\blacksquare R_{DS(ON) max} = 17m\Omega@V_{GS} = 4.5V$
- Extremely low switching loss
- Fast switching and soft recovery

Package Type



Application

- Charging Circuit
- Battery Applications
- Synchronous Rectification
- High Frequency Switching

Package Type of WLDE003R170NA

Ordering Information

Product Name	Package	Marking
WLDE003R170NA	DFN3*3	003R170

17mΩ, 30V, N-Channel Power MOSFET

WLDE003R170NA

Absolute Maximum Ratings

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	$V_{ m DS}$	30	V
Gate-Source Voltage	V_{GS}	±8	V
Continuous Drain Current ^{Note 1} , T _C =25°C	I_D	22	A
Pulsed Drain Current ^{Note 2}	I_{DM}	66	A
Max Power Dissipation Note 3, T _C =25°C	P_{D}	19.4	W
Avalanche Current, Single Pulse Note 5	I _{AS}	40.34	A
Avalanche Energy, Single Pulse Note 5	Eas	244.1	mJ
Operation Junction temperature	T _J	-55 to 150	°C

Thermal Resistance

Parameter	Symbol	Min	Тур	Max	Unit
Thermal Resistance, Junction-to-Case	$R_{ heta JC}$		6.45		°C/W
Thermal Resistance, Junction-to-Ambient ^{Note4}	$R_{ heta JA}$		62		°C/W

Notes:

- 1) Calculated continuous current based on maximum allowable junction temperature.
- 2) Repetitive rating; pulse width limited by max. junction temperature.
- 3) P_D is based on max. junction temperature, using junction-case thermal resistance.
- 4) The value of $R_{\theta JA}$ is measured with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with Ta=25 °C.
- 5) V_{DS} =15V, V_{GS} =4.5V, L=0.3mH, Rg=25Ω, starting T_{J} =25 °C.

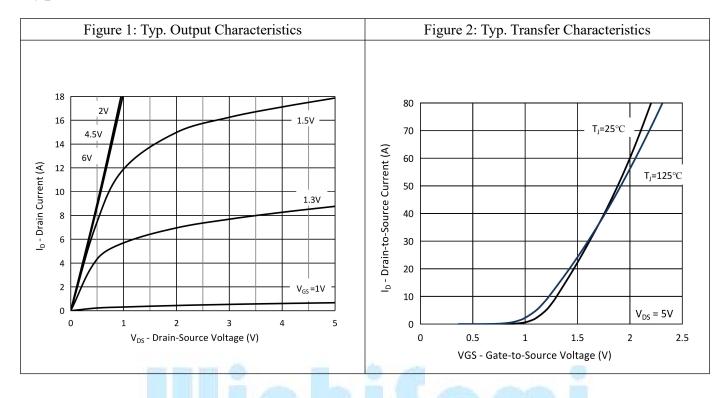
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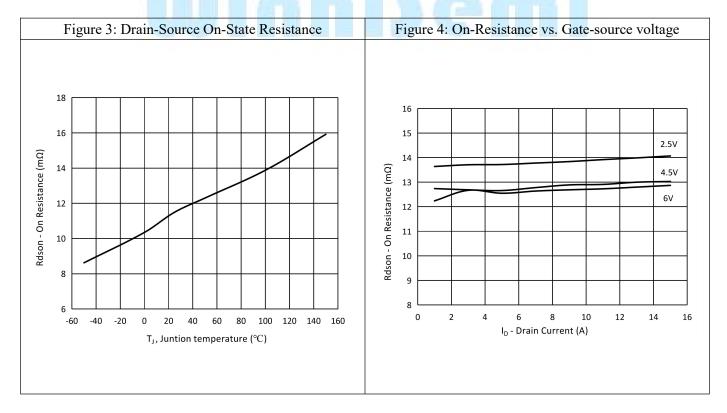
WLDE003R170NA

Electrical Characteristics (T_J= 25 °C, unless otherwise specified)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit	
Statistic Characteristics							
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V, I _D =250uA	30			V	
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=30V, V_{GS}=0V$			1	uA	
Gate-Body Leakage Current	I _{GSS}	$V_{GS}=\pm 8V, V_{DS}=0V$			±100	nA	
Gate Threshold Voltage	V _{GS(TH)}	$V_{DS}=V_{GS}$, $I_D=250uA$	0.35	0.55	0.85	V	
	D	V_{GS} =4.5V, I_{D} =5A		13.5	17	m Ω	
Static Drain-Source On-Resistance	R _{DS(ON)}	V_{GS} =4.5V, I_{D} =15A		13.6	17	$m\Omega$	
Gate Resistance	R_G	f=1MHz, open drain		0.63		Ω	
Dynamic Characteristics							
Input Capacitance	C _{iss}	V _{GS} =0V		860.8		pF	
Output Capacitance	C_{oss}	$V_{DS}=15V$		568.7		pF	
Reverse Transfer Capacitance	C_{rss}	f=1MHz		38.2		pF	
Turn-on Delay Time	t _{d(on)}	$V_{DS}=15V$		9.3			
Rise Time	$t_{\rm r}$	$V_{GS}=4.5V$		3.4			
Turn-off Delay Time	$t_{d(off)}$	$I_D=6A$ $R_G=3\Omega$		33.4		ns	
Fall Time	t_{f}			13			
Switching Characteristics							
Total Gate Charge (@VGS=8V)	Q_{g}	V _{GS} =0 to 8V		25.58			
Total Gate Charge (@VGS=4.5V)	Q_{g}	$V_{GS}=0.08V$ $V_{DS}=10V$		15.34		nC	
Gate to Source Charge	Q_{gs}	$I_{D}=15A$		1.54		IIC .	
Gate to Drain Charge	Q_{gd}			5.32			
Reverse Diode Characteristics							
Drain-Source Diode Forward Voltage	V _{SD}	V _{GS} =0V, I _{SD} =12A		0.85	1.2	V	
Reverse Recovery Time	t _{rr}	V _{DS} =10V		35.89		ns	
Reverse Recovery Charge	Qrr	$I_F=12A$		21.27		nC	
Peak Reverse Recovery Current	I _{rrm}	di/dt=100A/us		0.99		A	

Typical Performance Characteristics





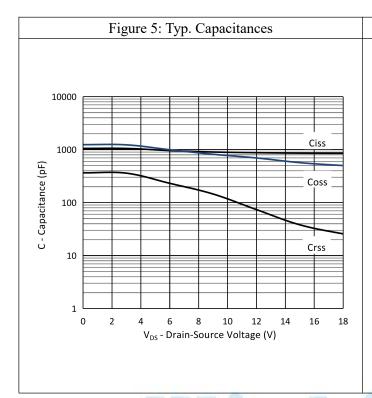
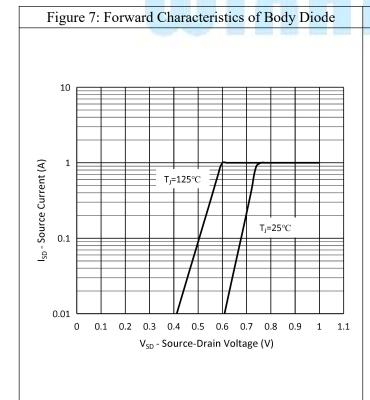
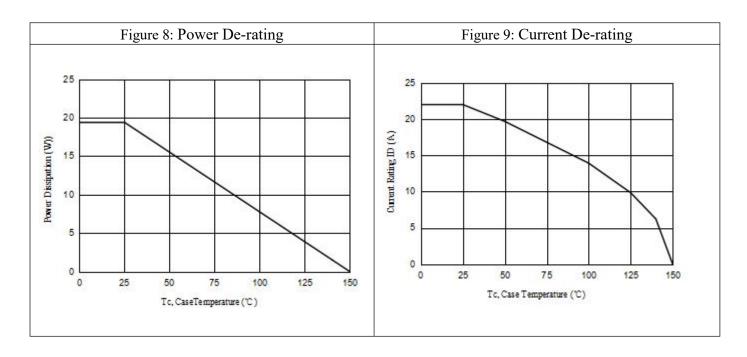
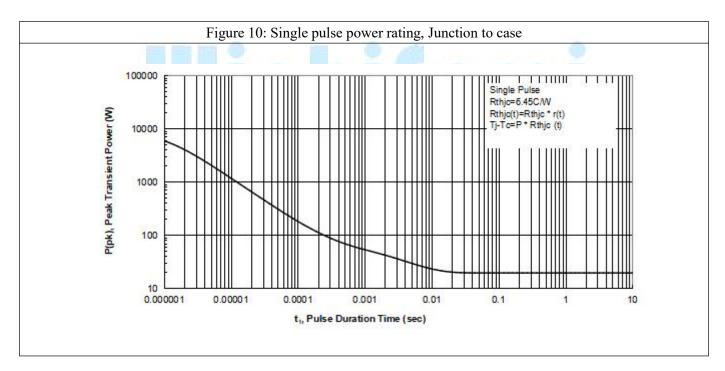
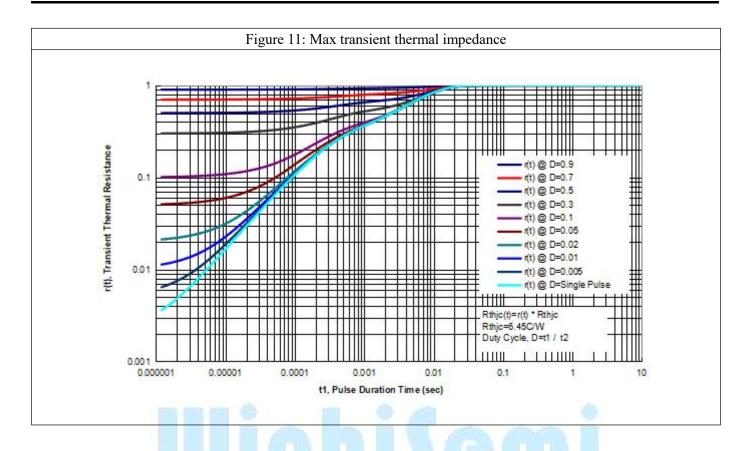


Figure 6: Gate Charge Characteristics

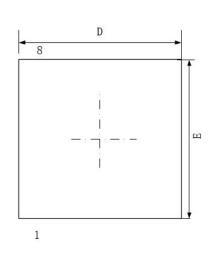


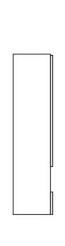


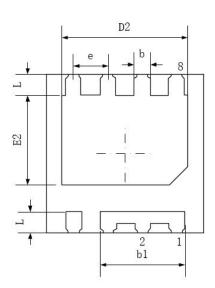


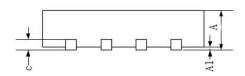


Mechanical Dimensions (DFN3*3 Unit:mm)









MILLMETER			
MIN	NOM	MAX	
0.70	0.75	0.80	
0.00	0.02	0.05	
0.25	0.30	0.35	
1.55	1.60	1.65	
0.19	0.20	0.21	
2.90	3.00	3.10	
2.30	2.40	2.50	
2.90	3.00	3.10	
1.60	1.70	1.80	
0.65BSC			
0.35	0.40	0.45	
	MIN 0.70 0.00 0.25 1.55 0.19 2.90 2.30 2.90 1.60	MIN NOM 0.70 0.75 0.00 0.02 0.25 0.30 1.55 1.60 0.19 0.20 2.90 3.00 2.30 2.40 2.90 3.00 1.60 1.70 0.65BSC	

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